



SHEET 1 OF 1

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Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEA. DOCKET NO.  
0327-0759-0SERIAL NO.  
09/220,691

## LIST OF REFERENCES CITED BY APPLICANT

## APPLICANT

Naoko TSUJI, et al.

FILING DATE: December 28, 1998  
CPA FILED: October 11, 2001  
RCE FILED: February 1, 2002

GROUP 1651

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
JWC	AA	4,720,489	01/19/88	D SHANDER			
JWC	AB	5,095,007	03/10/92	G. S. AHLUWALIA			
JWC	AC	5,096,911	03/17/92	G. S. AHLUWALIA, et al.			
JWC	AD	5,132,293	07/21/92	D SHANDER, et al.			
JWC	AE	5,364,885	11/15/94	G. S. AHLUWALIA, et al.			
JWC	AF	5,411,991	05/02/95	D SHANDER, et al.			
JWC	AG	5,554,608	09/10/96	G. S. AHLUWALIA, et al.			
JWC	AH	5,648,394	07/15/97	B. A. BOXALL, et al.			
JWC	AI	5,652,273	07/29/97	J. HENRY, et al.			
JWC	AJ	5,674,477	10/07/97	G. S. AHLUWALIA			
JWC	AK	5,776,442	07/07/98	G. S. AHLUWALIA			
JWC	AL	5,824,665	10/20/98	J. HENRY, et al.			
JWC	AM	5,908,867	06/01/99	J. P. HENRY, et al.			
JWC	AN	5,939,458	08/17/99	J. P. HENRY, et al.			
JWC	AO	5,958,946	09/28/99	P. STYCZYNSKI, et al.			
JWC	AP	6,020,006	02/01/2000	P. STYCZYNSKI, et al.			
JWC	AQ	6,037,326	03/14/2000	P. STYCZYNSKI, et al.			
JWC	AR	6,060,471	05/09/2000	P. STYCZYNSKI, et al.			
JWC	AS	6,093,748	07/25/2000	G. S. AHLUWALIA, et al.			
JWC	AT	6,218,435	04/17/2001	J. HENRY, et al.			
JWC	AU	6,239,170	05/29/2001	G. S. AHLUWALIA, et al.			
JWC	AV	6,248,751	06/19/2001	G. S. AHLUWALIA, et al.			

## FOREIGN PATENT DOCUMENTS

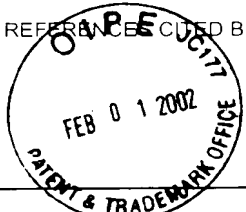
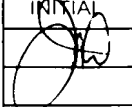
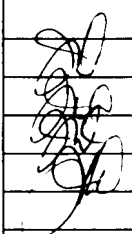
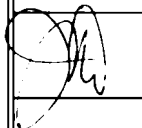
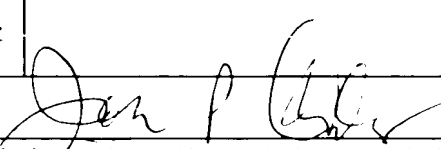
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JWC	AW	60-181007	09/14/85	JAPAN (with English translation)	✓	
	AX					
	AY					
	AZ					

Examiner

Date Considered

5 Aug 02

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. <b>0327-0759-0</b>		SERIAL NO. <b>09/220.691</b>	
LIST OF REFERENCES CITED BY APPLICANT 				APPLICANT <b>Naoko TSUJI, et al.</b>			
				FILING DATE: <b>December 28, 1998</b> <b>Notice of Allowance: November 1, 2001</b> <b>Batch No.: 022</b> <b>RCE Filed Herewith</b>		GROUP <b>1651</b>	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	4,513,009	04/23/85	Roques, et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
<b>FOREIGN PATENT DOCUMENTS</b>							
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	AO	JP5-105698	04/27/93	JAPAN (w. 1p. English Abstract)	<input checked="" type="checkbox"/>		
	AP	WO 92/03140	03/05/92	WIPO			
	AQ	WO 94/10967	05/26/94	WIPO			
	AR	JP8-133936	05/28/96	JAPAN (w. 1p. English Abstract)	<input checked="" type="checkbox"/>		
	AS						
	AT						
	AU						
	AV						
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
	AW	Journal of Dermatological Science 7 (1994) 202-209. Ralf Paus, Niels Krejci-Papa, Lingna Li, Beate M. Czarnetzki, Robert M. Hoffman					
	AX						
	AY						
	AZ						
Examiner 					Date Considered <b>5 Aug 02</b>		

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